

SILICON HIGH SPEED POWER TRANSISTOR

2SC 2527

September 1979

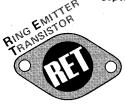


The 2SC 2527 is silicon NPN general purpose, high power switching transistors fabricated with Fujitsu's unique Ring Emitter Transistor (RET) technology. RET devices are constructed with multiple emitters connected through diffused ballast resistors which provide uniform current density. This structure permits the design of high power transistors with exceptional switching characteristics and frequency response in high current applications.

The 2SC 2527 is especially well-suited for High frequency power amplifiers, Audio power amplifiers, Switching regulators and DC-DC Converters.

A PNP complement, 2SA 1077 is available.

- High f_T = 80 MHz (typ)
- Ultra fast switching speed
- Excellent Safe Operating Area
- Improved reverse Second-Breakdown Capability



0.413 MAX (10.5 MAX.)		0.169 MAX. (4.3 MAX.)
	φ0.146 ⊂ (∌3.7)	0,047
	0.244 (6.2) 0.606 MAX (15.4 MAX.)	0.6)
	0248 MAX. (6.3 MAX.) (6.3 MAX.) (12.7 MIN.)	
70.197 (5.0)	0.03 WWW.XXX WWW.XXX 0 110 WWW.XXX	
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ABSOLUTE MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Collector to Base Voltage	V _{CBO}	120	V
Emitter to Base Voltage	V _{EBO}	7	V
Collector to Emitter Voltage	V _{CEO}	120	V
Collector Current	Ic	10	Α
Collector Power Dissipation (T _C = 25°C)	P _C	60	W
Junction Temperature	Тј	150	°C
Storage Temperature Range	T _{stg}	-65~+150	°C

ELECTRICAL CHARACTERISTICS $(T_a = 25^{\circ}C)$

Parameter	Symbol	Test Conditions	Limits			
			Min.	Тур.	Max.	Unit
Collector Cutoff Current	Ісво	V _{CB} = 120V, I _E = 0	_	_	50	μΑ
Emitter Cutoff Current	I _{EBO}	V _{EB} = 7V, I _C = 0	_	_	50	μΑ
Collector Cutoff Current	I _{CEO}	V _{CE} = 120V, I _B = 0	_	_	1	mA
Collector to Base Breakdown Voltage	V _{(BR)CBO}	$I_{C} = 50\mu A, I_{E} = 0$	120	. –	_	V
Emitter to Base Breakdown Voltage	V _{(BR)EBO}	$1E = 50\mu A, I_C = 0$	7	_	_	V
Collector to Emitter Breakdown Voltage	V _{(BR)CEO}	I _C = 1mA, R _{BE} = ∞	120	_	_	· V
DC Current Gain *	h _{FE1}	V _{CE} = 5V, I _C = 1A *	60	_	200	
DC Current Gain	h _{FE2}	V _{CE} = 5V, I _C = 5A *	40	_	_	
Collector to Emitter Saturation Voltage	V _{CE(sat)}	I _C = 5A, I _B = 0.5A *	_	0.7	1.8	V V
Base to Emitter Voltage	V _{BE}	V _{CE} = 5V, I _C = 5A *	_	1.25	1.7	V
Gain-Bandwidth Product	f _T	V _{CE} = 10V, I _C = 1 A, f = 10MHz	40	80	_	MHz
Output Capacitance	C _{ob}	V _{CB} = 10V, I _E = 0, f = 1MHz	_	180	300	pF
Rise Time	t _r	1 754 5	_	0.3	_	μs
Storage Time	t _{stg}	$I_C = 7.5A, R_L = 4\Omega$	_	1.3	_	μs
Fall Time	t _f	$I_{B1} = -I_{B2} = 0.75A$		0.2	_	μs